

Notice of References Cited	Application/Control No. 10/787,295		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner VIJAY SHANKAR		Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,510,805	04-1996	Lee, Sywe N.	345/58
*	B	US-5,648,790	07-1997	Lee, Sywe N.	345/58
*	C	US-6,448,718	09-2002	Battersby, Stephen J.	315/169.3
*	D	US-6,882,103	04-2005	Kim et al.	313/504
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.